







**BQ25172** SLUSDY5 - JUNE 2022

# BQ25172: 800-mA Linear Battery Charger for 1- to 6-Cell NiMH Batteries

## 1 Features

- Input voltage up to 30-V tolerant
- Automatic Sleep Mode for low power consumption
  - 350-nA battery leakage current
  - 85-µA input leakage current when charge disabled
- Supports 1- to 6-cell NiMH with intermittentcharging
- External resistor programmable operation
  - VSET to set NiMH series cell-count from 1s to 6s
  - ISET to set charge current from 10 mA to 800 mΑ
  - TMR to set charge safety timer duration from 4 hr to 22 hr
- High accuracy
  - ±0.5% charge voltage accuracy
  - ±10% charge current accuracy
- Charging features
  - NTC thermistor input to monitor battery temperature
  - Cold and hot temperature charging disabled
  - V<sub>OUT OVP</sub> reduced at cool temperatures
  - TS pin for charging function control
  - Open-drain output for status and fault indication
- Integrated fault protection
  - 18-V IN overvoltage protection
  - VSET based OUT overvoltage protection
  - 1000-mA overcurrent protection
  - 125°C thermal regulation; 150°C thermal shutdown protection
  - OUT short-circuit protection
  - VSET, ISET, TMR pins short/open protection

## 2 Applications

- · Fleet management, asset tracking
- Gas detector
- Electronic point of sales (ePOS)
- Beauty and grooming
- Electric toothbrush ٠
- Pulse oximeter
- Blood glucose monitor
- Infrared thermometer

## **3 Description**

The BQ25172 is an integrated 800-mA linear charger for 1-cell to 6-cell NiMH batteries targeted at industrial and medical applications. The device has a single power output that charges the battery. The system load can be placed in parallel with the battery, as long as the average system load does not prevent the battery from being charged fully within the safety timer duration. When the system load is placed in parallel with the battery, the charge current is shared between the system and the battery.

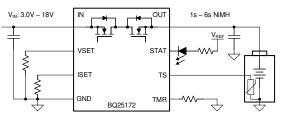
The device charges NiMH cells in constant current mode only and terminates the charge cycle when the programmable timer expires or the battery voltage exceeds the V<sub>OUT OVP</sub> threshold. In all charge phases, an internal control loop monitors the IC junction temperature and reduces the charge current if an internal temperature threshold T<sub>REG</sub>, is exceeded.

The charger power stage and charge current sense functions are fully integrated. The charger function has high accuracy current, charge status display, and timer-based charge termination. The series cell-count, charge current, and charge timer are programmable through external resistors. Intermittent charging allows a NiMH battery to automatically recharge for a reduced timer duration once its voltage falls below the recharge threshold.

#### **Device Information**

PART NUMBER	PACKAGE <sup>(1)</sup>	BODY SIZE (NOM)		
BQ25172	WSON (8)	2.0 mm x 2.0 mm		

(1)For all available packages, see the orderable addendum at the end of the data sheet.



Simplified Schematic





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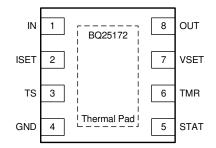
# **4 Revision History**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
June 2022	*	Initial Release



# **5** Pin Configuration and Functions



# Figure 5-1. DSG Package WSON 8-Pin Top View

### Table 5-1. Pin Functions

P	PIN		DESCRIPTION	
NAME	NUMBER	I/O	DESCRIPTION	
IN	1	Р	Input power, connected to external DC supply. Bypass IN with a $\geq$ 1-µF capacitor to GND, placed close to the IC.	
ISET	2	I	Programs the device charge current. External resistor from ISET to GND defines charge current value. Expected range is 30 k $\Omega$ (10 mA) to 375 $\Omega$ (800 mA). ICHG = K <sub>ISET</sub> / R <sub>ISET</sub> .	
TS	3	I	Temperature qualification voltage input. Connect a negative temperature coefficient (NTC) thermistor directly from TS to GND (AT103-2 recommended). Charge suspends when the TS pin voltage is out of range. VOUT_OVP is reduced in cool region. If TS function is not needed, connect an external 10-k $\Omega$ resistor from this pin to GND. Pulling V <sub>TS</sub> < V <sub>TS_ENZ</sub> disables the charger.	
GND	4	-	Ground pin	
STAT	5	0	Open drain charge status indication output. Connect to the pullup rail via a 10-k $\Omega$ resistor. LOW indicates charge in progress. HIGH indicates charge complete or charge disabled. When a fault condition is detected, the STAT pin blinks at 1 Hz.	
TMR	6	I	Connect to a pulldown resistor to program charge safety timer duration. Valid resistor range is 3.6 k $\Omega$ to 36 k $\Omega$ . Refer to Section 7.3.1.2.	
VSET	7	I	Programs the number of series NiMH cells. Valid resistor range is 3.6 k $\Omega$ to 62 k $\Omega$ . Recommend using a ±1% tolerance resistor with <200 ppm/°C temperature coefficient. Refer to Section 7.3.1.3.	
OUT	8	Р	Battery connection. System load may be connected in parallel to the battery. Bypass OUT with a ≥1-µF capacitor to GND, placed close to the IC.	
Thermal Pad	—	—	Exposed pad beneath the IC for heat dissipation. Solder thermal pad to the board with vias connecting to solid GND plane.	



# **6** Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Voltage	IN	-0.3	30	V
Voltage	OUT	-0.3	13	V
Voltage	ISET, STAT, TMR, TS, VSET	-0.3	5.5	V
Output Sink Current	STAT		5	mA
Junction temperature, T <sub>J</sub>		-40	150	°C
Storage temperature, T <sub>stg</sub>		-65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute maximum ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If briefly operating outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not sustain damage, but it may not be fully functional. Operating the device in this manner may affect device reliability, functionality, performance, and shorten the device lifetime.

### 6.2 ESD Ratings

			VALUE	UNIT	
V	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/ JEDEC JS-001, all pins <sup>(1)</sup>	±2500	V	
V <sub>(ESD)</sub>		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	±1500	V	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MA	X UNIT
V <sub>IN</sub>	Input voltage	3.0	1	8 V
V <sub>OUT</sub>	Output voltage		10.	5 V
I <sub>OUT</sub>	Output current		0.	8 A
TJ	Junction temperature	-40	12	5 °C
C <sub>IN</sub>	IN capacitor	1		μF
C <sub>OUT</sub>	OUT capacitor	1		μF
R <sub>TMR</sub>	TMR resistor	3.6	3	6 kΩ
R <sub>VSET</sub>	VSET resistor	3.6	6	2 kΩ
R <sub>TMR_VSET_TOL</sub>	Tolerance for TMR, and VSET resistors	-1		1 %
R <sub>TMR_VSET_TEMPCO</sub>	Temperature coefficient for TMR, and VSET resistors		20	0 ppm/°C
R <sub>ISET</sub>	ISET resistor	0.375	3	0 kΩ
R <sub>TS</sub>	TS thermistor resistor (recommend 103AT-2)		10	kΩ



### 6.4 Thermal Information

		BQ25172	
	THERMAL METRIC <sup>(1)</sup>	DSG(WSON)	UNIT
		8 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance (JEDEC <sup>(1)</sup> )	75.2	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	93.4	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	41.8	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	3.8	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	41.7	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	17.0	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



### **6.5 Electrical Characteristics**

 $3.0V < V_{IN} < 18V$  and  $V_{IN} > V_{OUT} + V_{SLEEP}$ ,  $T_J = -40^{\circ}C$  to  $+125^{\circ}C$ , and  $T_J = 25^{\circ}C$  for typical values (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	,
QUIESCENT C	URRENTS					
		OUT= 4.2V, IN floating or IN = 0V - 5V, Charge Disabled, $T_J = 25 ^{\circ}\text{C}$		0.350	0.6	μA
IQ_OUT	Quiescent output current (OUT)	OUT= 4.2V, IN floating or IN = 0V - 5V, Charge Disabled, $T_J < 105 ^{\circ}\text{C}$		0.350	0.8	μA
		OUT = 8.4V, IN floating or IN = 0V - 14V, Charge Disabled, $T_J$ = 25 °C		0.8	1.2	μA
IQ_OUT	Quiescent output current (OUT)	OUT = 8.4V, IN floating or IN = 0V - 14V, Charge Disabled, $T_J < 105 ^{\circ}\text{C}$		0.8	1.5	μA
I <sub>SD_IN_TS</sub>	Shutdown input current (IN) with charge disabled via TS pin	IN = 5V, Charge Disabled (V <sub>TS</sub> < V <sub>TS_ENZ</sub> ), no battery		80	110	μA
ISTANDBY_IN	Standby input current (IN) with charge terminated	IN = 5V, Charge Enabled, charge terminated		190		μA
ISTANDBY_IN	Standby input current (IN) with charge terminated	IN = 14V, Charge Enabled, charge terminated		230		μA
I <sub>Q_IN</sub>	Quiescent input current (IN)	IN = 5V, OUT = 3.8V, Charge Enabled, ICHG = 0A		0.45	0.6	mA
I <sub>Q_IN</sub>	Quiescent input current (IN)	IN = 14V, OUT = 7.6V, Charge Enabled, ICHG = 0A		0.45	0.6	mA
INPUT		· · · · ·				
V <sub>IN_OP</sub>	IN operating range		3.0		18	V
V <sub>IN_LOWV</sub>	IN voltage to start charging	IN rising	3.05	3.09	3.15	V
V <sub>IN_LOWV</sub>	IN voltage to stop charging	IN falling	2.80	2.95	3.10	V
V <sub>SLEEPZ</sub>	Exit sleep mode threshold	IN rising, $V_{IN} - V_{OUT}$ , OUT = 4V	95	135	175	mV
V <sub>SLEEP</sub>	Sleep mode threshold hysteresis	IN falling, $V_{IN} - V_{OUT}$ , OUT = 4V		80		mV
V <sub>IN_OV</sub>	VIN overvoltage rising threshold	IN rising	18.1	18.4	18.7	V
V <sub>IN_OVZ</sub>	VIN overvoltage falling threshold	IN falling		18.2		V
CONFIGURATI	ON PINS SHORT/OPEN PROTECTION					
R <sub>ISET_SHORT</sub>	Resistor value considered short	R <sub>ISET</sub> below this at startup, charger does not initiate charge, power cycle or TS toggle to reset			350	Ω
R <sub>VSET_SHORT</sub>	Resistor value considered short	R <sub>VSET</sub> below this at startup, charger does not initiate charge, power cycle or toggle to reset			2.8	kΩ
R <sub>VSET_OPEN</sub>	Resistor value considered open	R <sub>VSET</sub> above this at startup, charger does not initiate charge, power cycle or toggle to reset	80			kΩ
R <sub>TMR_SHORT</sub>	Resistor value considered short	R <sub>TMR</sub> below this at startup, charger latches off, power cycle or TS toggle to reset			2.8	kΩ
R <sub>TMR_OPEN</sub>	Resistor value considered open	R <sub>TMR</sub> above this at startup, charger latches off, power cycle or TS toggle to reset	45			kΩ
BATTERY CHA	RGER					
I <sub>CHG_RANGE</sub>	Typical charge current regulation range		10		800	mA
K <sub>ISET</sub>	Charge current setting factor, $I_{CHG} = K_{ISET} / R_{ISET}$	10mA < ICHG < 800mA	270	300	330	AΩ
		R <sub>ISET</sub> = 375Ω, OUT = 3.8V	720	800	880	mA
lava var	Charge current accuracy	R <sub>ISET</sub> = 600Ω, OUT = 3.8V	450	500	550	mA
CHG_ACC		R <sub>ISET</sub> = 3.0kΩ, OUT = 3.8V	90	100	110	mA
		R <sub>ISET</sub> = 30kΩ, OUT = 3.8V	9	10	11	mA



# 6.5 Electrical Characteristics (continued)

 $3.0V < V_{IN} < 18V$  and  $V_{IN} > V_{OUT} + V_{SLEEP}$ ,  $T_J = -40^{\circ}C$  to  $+125^{\circ}C$ , and  $T_J = 25^{\circ}C$  for typical values (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>RECHG</sub>	Battery recharge threshold, per cell	OUT falling, VSET configured for 2-cell	1.305	1.330	1.355	V
D		IOUT = 400mA, T <sub>J</sub> = 25°C		845	1000	mΩ
R <sub>ON</sub>	Charging path FET on-resistance	IOUT = 400mA, T <sub>J</sub> = -40 - 125°C		845	1450	mΩ
BATTERY CHAR	GER PROTECTION	I				
V <sub>OUT_OVP</sub>	OUT overvoltage rising threshold, per cell	VOUT rising, TS normal	1.65	1.70	1.75	v
V <sub>OUT_OVP</sub>	OUT overvoltage falling threshold, per cell	VOUT falling, TS normal	1.40	1.45	1.50	V
V <sub>OUT_OVP_TSCOOL</sub>	OUT overvoltage rising threshold, per cell	VOUT rising, TS in cool range	1.45	1.50	1.55	V
VOUT_OVP_TSCOOL	OUT overvoltage falling threshold, per cell	VOUT falling, TS in cool range	1.30	1.35	1.40	V
I <sub>OUT_OCP</sub>	Output current limit threshold	IOUT rising	0.9	1	1.1	А
TEMPERATURE	REGULATION AND TEMPERATURE SI	HUTDOWN	- I			
T <sub>REG</sub>	Typical junction temperature regulation			125		°C
<b>-</b>	Thermal shutdown rising threshold	Temperature increasing		150		°C
T <sub>SHUT</sub>	Thermal shutdown falling threshold	Temperature decreasing		135		°C
BATTERY-PACK	NTC MONITOR					
I <sub>TS_BIAS</sub>	TS nominal bias current		36.5	38	39.5	μA
	Cold temperature threshold	TS pin voltage rising (approx. 0°C)	0.99	1.04	1.09	V
V <sub>COLD</sub>	Cold temperature exit threshold	TS pin voltage falling (approx. 4°C)	0.83	0.88	0.93	V
V	Cool temperature threshold; V <sub>OUT_OVP</sub> reduced	TS pin voltage rising (approx. 10°C)	650	680	710	mV
V <sub>COOL</sub>	Cool temperature exit threshold; V <sub>OUT_OVP</sub> returns to normal	TS pin voltage falling (approx. 13°C)	580	610	640	mV
	Hot temperature threshold	TS pin voltage falling (approx. 45°C)	176	188	200	mV
V <sub>HOT</sub>	Hot temperature exit threshold	TS pin voltage rising (approx. 40°C)	208	220	232	mV
V <sub>TS_ENZ</sub>	Charge Disable threshold. Crossing this threshold shall shutdown IC	TS pin voltage falling	40	50	60	mV
V <sub>TS_EN</sub>	Charge Enable threshold. Crossing this threshold shall restart IC operation	TS pin voltage rising	65	75	85	mV
V <sub>TS_CLAMP</sub>	TS maximum voltage clamp	TS pin open-circuit (float)	2.3	2.6	2.9	V
LOGIC OUTPUT	PIN (STAT)	·				
V <sub>OL</sub>	Output low threshold level	Sink current = 5mA			0.4	V
I <sub>OUT_BIAS</sub>	High-level leakage current	Pull up rail 3.3V			1	μA
	1					

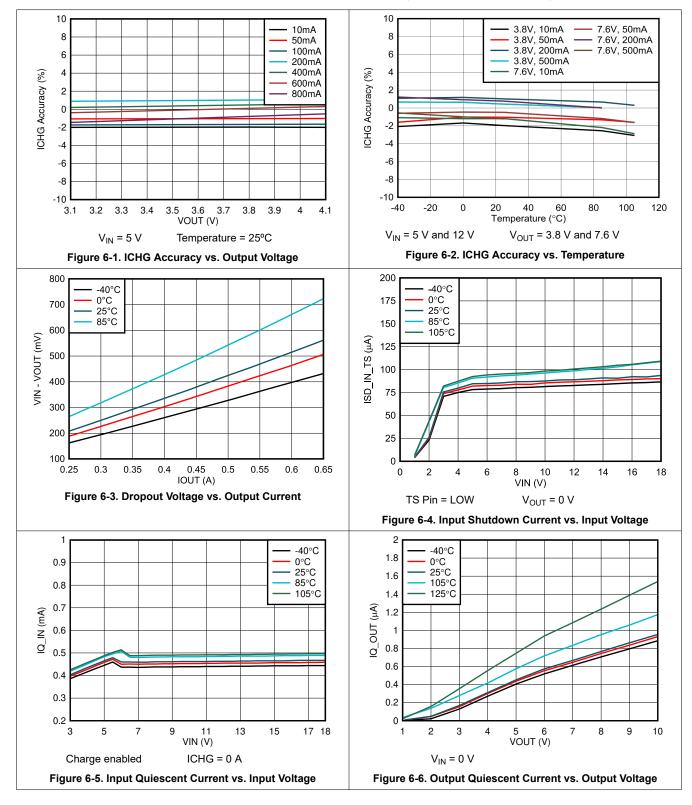
# 6.6 Timing Requirements

		MIN	NOM	MAX	UNIT
BATTERY CHARGER				·	
t <sub>TS_DUTY_ON</sub>	TS turn-on time during TS duty cycle mode		100		ms
tTS_DUTY_OFF	TS turn-off time during TS duty cycle mode		2		s
tout_ocp_dgl	Deglitch time for I <sub>OUT_OCP</sub> , IOUT rising		100		μs
t <sub>SAFETY</sub>	Charge safety timer accuracy, $R_{TMR}$ = 18k $\Omega$	9.5	10	10.5	hr
t <sub>INTERMITTENT</sub>	Commercial Intermittent charge safety timer (NiMH), as percentage of $t_{\mbox{SAFETY}}$		20		%



### **6.7 Typical Characteristics**

C<sub>IN</sub> = 1 µF, C<sub>OUT</sub> = 1 µF, V<sub>IN</sub> = 5 V, V<sub>OUT</sub> = 3.8 V, Temperature = Ambient (unless otherwise specified)





## 7 Detailed Description

### 7.1 Overview

The BQ25172 is an integrated 800-mA linear charger for 1-cell to 6-cell NiMH battery applications. The device has a single power output that charges the battery. When the system load is placed in parallel with the battery, the input current is shared between the system and the battery.

The device charges a NiMH battery in constant current mode only and terminates the charge cycle when the programmable timer,  $t_{SAFETY}$ , expires or the battery voltage exceeds the  $V_{OUT\_OVP}$  threshold. An optional intermittent charging phase can be programmed to automatically recharge the NiMH battery for a reduced timer duration once its voltage falls below  $V_{RECHG}$ .

The charger includes flexibility in programming of the charge current, charge safety timer duration, and series cell-count. This charger is designed to work with a standard USB connection or dedicated charging adapter (DC output).

The charger also comes with a full set of safety features: battery temperature monitoring, overvoltage protection, charge safety timer, and configuration pin (VSET, ISET, TMR) short and open protection. Upon application of a valid input power source, the configuration pins are checked for short and open circuits. All of these features and more are described in detail in the following sections.

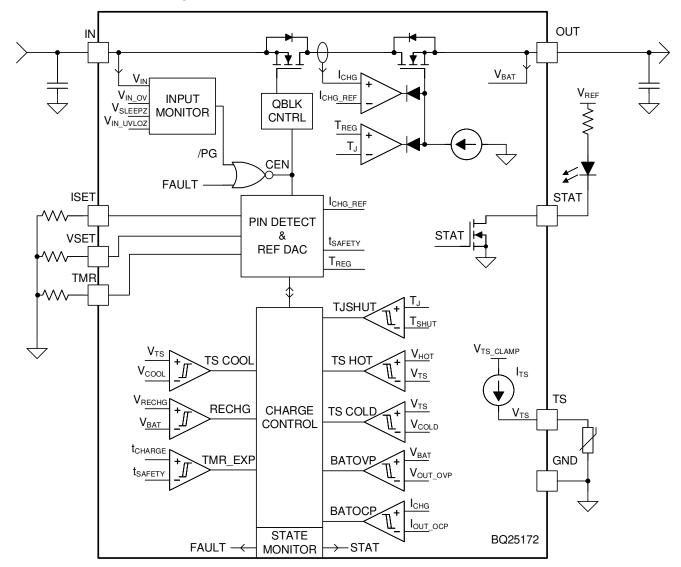
The charger is designed for a single path from the input to the output to charge the battery. Once the input adapter has been connected, the charge current is applied and the safety timer is started. The charge current is programmed using the ISET pin. The safety timer is programmed by the TMR pin.

Power dissipation in the IC is greatest at high charge currents and low battery voltages. If the IC temperature reaches  $T_{REG}$ , the IC enters thermal regulation, slows the timer clock by half, and reduces the charge current as needed to keep the temperature from rising any further.

Further details are described in Section 7.3.



## 7.2 Functional Block Diagram





### 7.3 Feature Description

#### 7.3.1 Device Power Up from Input Source

When an input source is plugged in and charge is enabled ( $V_{TS} > V_{TS\_EN}$ ), the device checks the input source voltage to turn on all the bias circuits. It detects and sets the charge current, safety timer length, and series cell-count before the linear regulator is started. The power-up sequence from input source is as listed:

- 1. ISET pin detection
- 2. TMR pin detection to select charge timer
- 3. VSET pin detection to select battery stack configuration
- 4. Charger power up

#### 7.3.1.1 ISET Pin Detection

After a valid VIN is plugged in and  $V_{TS} > V_{TS_EN}$ , the device checks the resistor on the ISET pin for a short circuit ( $R_{ISET} < R_{ISET_SHORT}$ ). If a short condition is detected, the charger remains in the FAULT state until the input or TS pin is toggled. If the ISET pin is open-circuit, the charger proceeds through pin detection and starts the charger with no charge current. The ISET pin is monitored while charging and changes in  $R_{ISET}$  while the charger is operating immediately translates to changes in charge current.

An external pulldown resistor (±1% or better is recommended to minimize charge current error) from the ISET pin to GND sets the charge current as:

 $I_{CHG} = \frac{K_{ISET}}{R_{ISET}}$ 

(1)

#### where:

- I<sub>CHG</sub> is the desired charge current
- K<sub>ISET</sub> is a gain factor found in the electrical characteristics
- R<sub>ISET</sub> is the pulldown resistor from the ISET pin to GND

For charge currents below 50 mA, an extra RC circuit is recommended on ISET to achieve a more stable current signal. For greater accuracy at lower currents, part of the current-sensing FET is disabled to give better resolution.

#### 7.3.1.2 TMR Pin Detection

The TMR pin is used to program the safety timer using a  $\pm 1\%$  pulldown resistor. The available pulldown resistors and corresponding timer lengths are listed in the following table.

CHARGE TIMER (HR)								
No charge (open-circuit)								
4 hr								
6 hr								
8 hr								
10 hr								
12 hr								
14 hr								
16 hr								
18 hr								
20 hr								
22 hr								

#### Table 7-1. TMR Pin Resistor Value Table



#### Table 7-1. TMR Pin Resistor Value Table (continued)

RESISTOR	CHARGE TIMER (HR)
< 3.0 kΩ	No charge (short-circuit)

If either a short- or open-circuit condition is detected, the charger stops operation and remains in the FAULT state until the input or TS pin is toggled.

Once a value has been detected, it is latched in and the pin is not continuously monitored during operation. A change in this pin is not acknowledged by the IC until the input supply or TS pin is toggled.

#### 7.3.1.3 VSET Pin Detection

The VSET pin is used to program the device cell configuration using a  $\pm 1\%$  pulldown resistor. The available pulldown resistors and corresponding cell configurations are listed in the following table.

Table 7-2. VSET Pin Resistor Value Table							
RESISTOR	CELL COUNT						
> 80 Ω	No charge (open-circuit)						
62 kΩ	1-cell						
47 kΩ	1-cell + intermittent charge						
36 kΩ	2-cell						
27 kΩ	2-cell + intermittent charge						
24 kΩ	3-cell						
18 kΩ	3-cell + intermittent charge						
15 kΩ	4-cell						
11 kΩ	4-cell + intermittent charge						
8.2 kΩ	5-cell						
6.2 kΩ	5-cell + intermittent charge						
4.7 kΩ	6-cell						
3.6 kΩ	6-cell + intermittent charge						
< 3.0 kΩ	No charge (short-circuit)						

If either a short- or open-circuit condition is detected, the charger stops operation and remains in the FAULT state until the input or TS pin is toggled.

Once a valid resistor value has been detected, the corresponding cell configuration is latched in and the pin is not continuously monitored during operation. A change in this pin is not acknowledged by the IC until the input supply or TS pin is toggled.

#### 7.3.1.4 Charger Power Up

After ISET, TMR, and VSET pin resistor values have been validated, the device proceeds to enable the charger. For more info see Section 7.3.2.1.

#### 7.3.2 Battery Charging Features

When charge is enabled ( $V_{TS} > V_{TS\_EN}$ ), the device automatically completes a charging cycle according to the settings on the ISET, TMR, and VSET pins. Charging is terminated when the charge safety timer expires or battery voltage exceeds  $V_{OUT}$  ovp.

#### 7.3.2.1 NiMH Battery Charging Profile

The device charges NiMH batteries in constant current mode only. The charge current programmed by ISET is the only current applied over the charging cycle, as shown in Figure 7-1. The charge termination method for the device is timer-based. The charge safety timer,  $t_{SAFETY}$ , sets the charging duration. Programming the charge safety timer is done with a pulldown resistor on the TMR pin.



Intermittent charging is designed to replenish the natural self-discharge of NiMH cells by restarting a short charge cycle (20% of  $t_{SAFETY}$ ) when the output voltage falls below the  $V_{RECHG}$  threshold. If the intermittent charging function is disabled and a full charge cycle has been completed (safety timer expired with  $V_{OUT}$  above  $V_{RECHG}$ ), the device does not start a new charge cycle automatically and requires input supply or TS pin toggle to initiate a new charge cycle.

If battery voltage is above  $V_{RECHG}$  at power up, the battery is considered full and the device does not charge. Once the battery voltage falls below  $V_{RECHG}$ , the device automatically begins charging. If the intermittent charging function is disabled, a single charge cycle is initiated with the safety timer duration programmed by the TMR pin. If intermittent charging is enabled, an intermittent charge cycle is initiated for 20% of the TMR programmed value.

When the charge timer (full-length or intermittent) expires, the battery voltage is checked again. If the battery voltage is below  $V_{RECHG}$ , a fault is reported through the STAT pin and further charging is prevented. If the charge timer expires with  $V_{OUT}$  above  $V_{RECHG}$ , the STAT pin indicates charge completed. In the case where the TS fault is within the cool threshold,  $V_{OUT}$  over is automatically reduced to  $V_{OUT}$  over TSCOOL voltage.

If the charger is in thermal regulation during charging, the actual charging current will be less than the programmed value. Termination by timer is still enabled, but the charging safety timer is counted at half the clock rate. For more information, refer to Section 7.3.2.2.

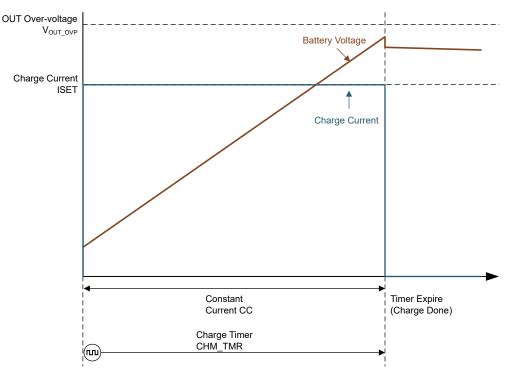


Figure 7-1. NiMH Battery Charging Profile with Intermittent Charging Disabled



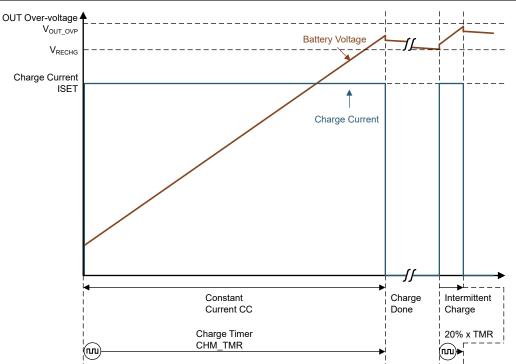


Figure 7-2. NiMH Battery Charging Profile with Intermittent Charging Enabled

### 7.3.2.2 Charging Safety Timers

The device has built-in safety timers to prevent an extended charging cycle due to abnormal battery conditions. When the safety timer expires, the charge cycle ends.

During thermal regulation, the safety timer counts at half the clock rate as the actual charge current is likely to be below the ISET setting. For example, if the charger is in thermal regulation throughout the whole charging cycle and the safety timer is 10 hours, then the timer will expire in 20 hours.

During faults which disable charging, such as VIN OVP, BAT OVP, TSHUT, or TS faults, the timer is suspended. If the charging cycle is stopped and started again, the timer is reset (toggle of the TS pin restarts the timer).

The safety timer restarts counting when the charging cycle stops and restarts. This can occur as a result of the TS pin being toggled, the battery falling below the recharge threshold, or the input supply being toggled.

### 7.3.2.3 Battery Cold, Hot Temperature Qualification (TS Pin)

While charging, the device continuously monitors battery temperature by sensing the voltage at the TS pin. A negative temperature coefficient (NTC) thermistor should be connected between the TS and GND pins (recommend: 103AT-2). If temperature sensing is not required in the application, connect a fixed 10-k $\Omega$  resistor from the TS pin to GND to allow normal operation. Battery charging is allowed when the TS pin voltage falls between the V<sub>COLD</sub> and V<sub>HOT</sub> thresholds (typically 0°C to 45°C).

If the TS pin indicates battery temperature is outside this range, the device stops charging and enters the Standby state. Once battery temperature returns to normal conditions, charging resumes automatically.

In addition to battery temperature sensing, the TS pin can be used to disable the charger at any time by pulling TS voltage below  $V_{TS\_ENZ}$ . The device disables the charger and consumes  $I_{SD\_IN\_TS}$  from the input supply. In order to minimize quiescent current, the TS current source ( $I_{TS\_BIAS}$ ) is duty-cycled, with an on time of  $t_{TS\_DUTY\_ON}$  and an off time of  $t_{TS\_DUTY\_OFF}$ . After the TS pin pulldown is released, the device may take up to  $t_{TS\_DUTY\_OFF}$  to turn  $I_{TS\_BIAS}$  back on. After the source is turned on, the TS pin voltage goes above  $V_{TS\_EN}$  and reenables charger operation. The device treats this TS pin toggle as an input supply toggle, triggering a device power up from input source (see Section 7.3.1).



### 7.3.3 Status Outputs (STAT)

### 7.3.3.1 Charging Status Indicator (STAT)

The device indicates the charging state on the open-drain STAT pin as listed in the following table. This pin can drive an LED.

Table 7-3. STAT PIT States								
CHARGING STATE	STAT PIN STATE							
Charge completed (TMR_EXP), charger in Sleep mode or charge disabled	High							
Charge in progress (including intermittent charge active)	Low							
Fault (VIN OVP, BAT OVP, BAT OCP, or VSET, ISET, TMR pin short or open)	Blink at 1 Hz							

#### Table 7-3. STAT Pin States

#### 7.3.4 Protection Features

The device closely monitors input and output voltages, as well as internal FET current and temperature for safe linear regulator operation.

#### 7.3.4.1 Input Overvoltage Protection (VIN OVP)

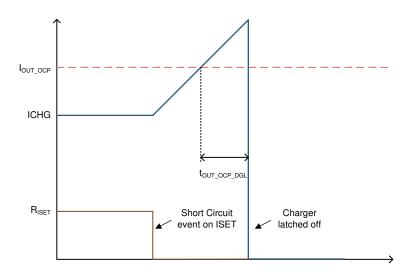
If the voltage at the IN pin exceeds  $V_{IN_OV}$ , the device turns off, the safety timer suspends counting, and the device enters Standby mode. Once the IN voltage recovers to a normal level, the charge cycle and the safety timer automatically resume operation.

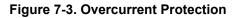
#### 7.3.4.2 Output Overvoltage Protection (BAT OVP)

If the voltage at the OUT pin exceeds  $V_{OUT_OVP}$ , the device immediately stops charging, the safety timer suspends counting, and the device enters Standby mode. Once the OUT voltage recovers to a normal level, the charge cycle and the safety timer resume operation.

#### 7.3.4.3 Output Overcurrent Protection (BAT OCP)

During normal operation, the OUT current should be regulated to the ISET programmed value. However, if a short circuit occurs on the ISET pin, the OUT current may rise to an unintended level. If the current at the OUT pin exceeds  $I_{OUT\_OCP}$ , the device turns off after a deglitch,  $t_{OUT\_OCP\_DGL}$ , the safety timer resets the count, and the device remains latched off. An input supply or pin toggle is required to restart operation.







#### 7.3.4.4 Thermal Regulation and Thermal Shutdown (TREG and TSHUT)

The device monitors its internal junction temperature  $(T_J)$  to avoid overheating and to limit the IC surface temperature. When the internal junction temperature exceeds the thermal regulation limit, the device automatically reduces the charge current to maintain the junction temperature at the thermal regulation limit (TREG). During thermal regulation, the safety timer runs at half the clock rate and the actual charging current is reduced below the programmed value on the ISET pin.

Additionally, the device has thermal shutdown to turn off the linear regulator when the IC junction temperature exceeds the TSHUT threshold. The charger resumes operation when the IC die temperature decreases below the TSHUT falling threshold.

#### 7.4 Device Functional Modes

#### 7.4.1 Shutdown or Undervoltage Lockout (UVLO)

The device is in the shutdown state if the IN pin voltage is less than  $V_{IN\_LOWV}$ . The internal circuitry is powered down, all the pins are high impedance, and the device draws from the input supply. Once the IN voltage rises above the  $V_{IN\_LOWV}$  threshold, the IC enters Sleep mode or Active mode depending on the OUT pin voltage.

#### 7.4.2 Sleep Mode

The device is in Sleep mode when  $V_{IN_LOWV} < V_{IN} < V_{OUT} + V_{SLEEPZ}$ . The device waits for the input voltage to rise above  $V_{OUT} + V_{SLEEPZ}$  to start operation.

#### 7.4.3 Active Mode

The device is powered up and charges the battery when the TS pin is above  $V_{TS\_ENZ}$  and the IN voltage ramps above both  $V_{IN\_LOWV}$  and  $V_{OUT}$  +  $V_{SLEEPZ}$ . The device draws  $I_{Q\_IN}$  from the supply to bias the internal circuitry. For details on the device power-up sequence, refer to Section 7.3.1.

#### 7.4.3.1 Standby Mode

The device is in Standby mode if a valid input supply is present and charge is terminated or if a recoverable fault is detected. The internal circuitry is partially biased, and the device continues to monitor for either  $V_{OUT}$  to drop below  $V_{RECHG}$  or the recoverable fault to be removed.

#### 7.4.4 Fault Mode

The fault conditions are categorized into recoverable and nonrecoverable as follows:

- Recoverable, from which the device should automatically recover once the fault condition is removed:
  - VIN OVP
  - BAT OVP
  - TS HOT
  - TS COLD
- Nonrecoverable, requiring pin or input supply toggle to resume operation:
  - BAT OCP
  - ISET pin short detected
  - Charge timer expires with V<sub>OUT</sub> below V<sub>RECHG</sub>



## 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 8.1 Application Information

A typical application consists of the device configured as a standalone battery charger for a 1-cell to 6-cell NiMH battery. The charge voltage and number of cells is configured using a pulldown resistor on the VSET pin. The charge current is configured using a pulldown resistor on the ISET pin. A battery thermistor may be connected to the TS pin to allow the device to monitor battery temperature and control charging. Pulling the TS pin below  $V_{TS\_ENZ}$  disables the charging function. The safety timer is programmable through a pullown resistor on the TMR pin. Faults are indicated through the STAT pin.

### **8.2 Typical Applications**

#### 8.2.1 NiMH Charger Design Example

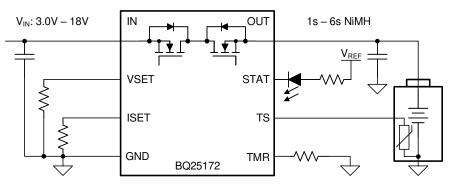


Figure 8-1. BQ25172 Simple Schematic

#### 8.2.1.1 Design Requirements

The design requirements include the following:

- Input supply up to 18 V
- Battery: 4-cell NiMH, R<sub>VSET</sub> = 11 kΩ
- Fast charge current: I<sub>CHG</sub> = 30 mA
- Recharge voltage for intermittent cycles: V<sub>RECHG</sub> = 1.33V x 4 = 5.32 V
- Charge safety timer: R<sub>TMR</sub> = 8.2 kΩ, t<sub>SAFETY</sub>: 16 hr
- TS Battery temperature sense =  $10-k\Omega$  NTC (103AT-2)
- TS can be pulled low to disable charging

#### 8.2.1.2 Detailed Design Procedure

The regulation voltage is set via the VSET pin to 2s NiMH, the input voltage is 5 V and the charge current is programmed via the ISET pin to 500 mA.

 $\begin{array}{l} \mathsf{R}_{\mathsf{ISET}} = [\mathsf{K}_{\mathsf{ISET}} \,/\, \mathsf{I}_{\mathsf{CHG}}] \\ \text{from electrical characteristics table. . . } \mathsf{K}_{\mathsf{ISET}} = 300 \ \mathsf{A}\Omega \\ \mathsf{R}_{\mathsf{ISET}} = [300 \ \mathsf{A}\Omega/0.5 \ \mathsf{A}] = 600 \ \Omega \\ \text{Selecting the closest 1\% resistor standard value, use a 604-} \Omega \ \text{resistor between ISET and GND, for an expected} \\ \mathsf{I}_{\mathsf{CHG}} \ 497 \ \text{mA.} \end{array}$ 



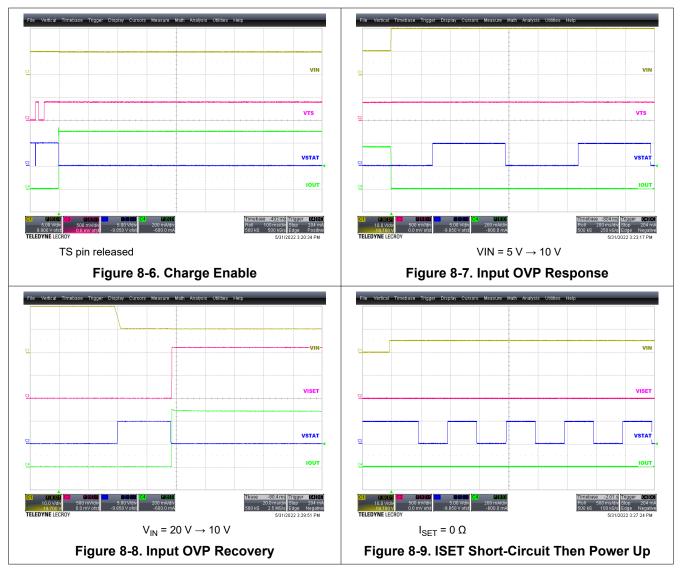
### 8.2.1.3 Application Curves

 $C_{IN}$  = 1 µF,  $C_{OUT}$  = 1 µF,  $V_{IN}$  = 5 V,  $V_{OUT}$  = 3.8 V (unless otherwise specified)





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## 9 Power Supply Recommendations

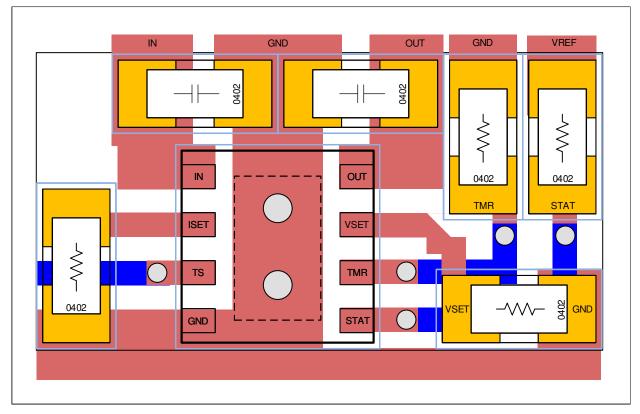
The device is designed to operate from an input voltage supply range between 3 V and 18 V (tolerant up to 30 V) and current capability of at least the maximum designed charge current. If located more than a few inches from the IN and GND pins, a larger capacitor is recommended.

## 10 Layout

### **10.1 Layout Guidelines**

To obtain optimal performance, the decoupling capacitor from the IN pin to the GND pin and the output filter capacitor from the OUT pin to the GND pin should be placed as close as possible to the device, with short trace runs to both IN, OUT, and GND.

- All low current GND connections should be kept separate from the high current charge or discharge paths from the battery. Use a single-point ground technique incorporating both the small signal ground path and the power ground path.
- The high current charge paths into the IN pin and from the OUT pin must be sized appropriately for the maximum charge current in order to avoid voltage drops in these traces.



### 10.2 Layout Example

Figure 10-1. BQ25172 Layout Example



## 11 Device and Documentation Support

#### **11.1 Device Support**

#### 11.1.1 Third-Party Products Disclaimer

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#### **11.2 Receiving Notification of Documentation Updates**

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **11.3 Support Resources**

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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#### **11.5 Electrostatic Discharge Caution**



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.6 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.



# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
BQ25172DSGR	ACTIVE	WSON	DSG	8	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	B172	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ25172DSGR	WSON	DSG	8	3000	180.0	8.4	2.3	2.3	1.15	4.0	8.0	Q2



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# PACKAGE MATERIALS INFORMATION

6-Jun-2022



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ25172DSGR	WSON	DSG	8	3000	210.0	185.0	35.0

# DSG 8

2 x 2, 0.5 mm pitch

# **GENERIC PACKAGE VIEW**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





# DSG0008A



# **PACKAGE OUTLINE**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.

3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



# DSG0008A

# **EXAMPLE BOARD LAYOUT**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

 Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



# DSG0008A

# **EXAMPLE STENCIL DESIGN**

# WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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